

Notice of References Cited	Application/Control No. 09/704,595	Applicant(s)/Patent Under Reexamination AKKERMANS, ANTONIUS H.M.	
	Examiner Jorge L Ortiz-Criado	Art Unit 2697	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,561,082	12-1985	Gerard et al.	369/44.34
*	B	US-5,636,197	06-1997	Tateishi, Kiyoshi	369/44.34
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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